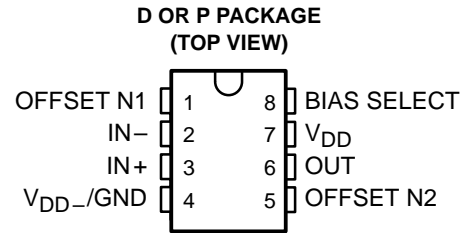


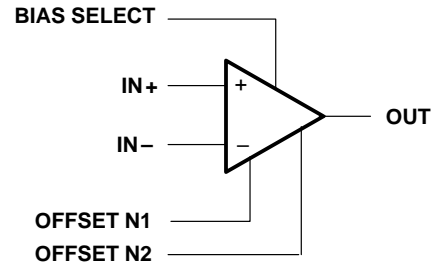
TLC251, TLC251A, TLC251B, TLC251Y LinCMOS™ PROGRAMMABLE LOW-POWER OPERATIONAL AMPLIFIERS

SLOS001E – JULY 1983 – REVISED AUGUST 1994

- **Wide Range of Supply Voltages**
1.4 V to 16 V
- **True Single-Supply Operation**
- **Common-Mode Input Voltage Range**
Includes the Negative Rail
- **Low Noise . . . 30 nV/ $\sqrt{\text{Hz}}$ Typ at 1 kHz**
(High Bias)
- **ESD Protection Exceeds 2000 V Per**
MIL-STD-883C, Method 3015.1



symbol



description

The TLC251C, TLC251AC, and TLC251BC are low-cost, low-power programmable operational amplifiers designed to operate with single or dual supplies. Unlike traditional metal-gate CMOS operational amplifiers, these devices utilize Texas Instruments silicon-gate LinCMOS™ process, giving them stable input offset voltages without sacrificing the advantages of metal-gate CMOS.

This series of parts is available in selected grades of input offset voltage and can be nulled with one external potentiometer. Because the input common-mode range extends to the negative rail and the power consumption is extremely low, this family is ideally suited for battery-powered or energy-conserving applications. A bias-select pin can be used to program one of three ac performance and power-dissipation levels to suit the application. The series features operation down to a 1.4-V supply and is stable at unity gain.

These devices have internal electrostatic-discharge (ESD) protection circuits that prevent catastrophic failures at voltages up to 2000 V as tested under MIL-STD-883C, Method 3015.1. However, care should be exercised in handling these devices as exposure to ESD may result in a degradation of the device parametric performance.

Because of the extremely high input impedance and low input bias and offset currents, applications for the TLC251C series include many areas that have previously been limited to BIFET and NFET product types. Any circuit using high-impedance elements and requiring small offset errors is a good candidate for cost-effective use of these devices. Many features associated with bipolar technology are available with LinCMOS™ operational amplifiers without the power penalties of traditional bipolar devices. Remote and inaccessible equipment applications are possible using the low-voltage and low-power capabilities of the TLC251C series.

In addition, by driving the bias-select input with a logic signal from a microprocessor, these operational amplifiers can have software-controlled performance and power consumption. The TLC251C series is well suited to solve the difficult problems associated with single battery and solar cell-powered applications.

The TLC251C series is characterized for operation from 0°C to 70°C.

AVAILABLE OPTIONS

T _A	V _{IOmax} AT 25°C	PACKAGED DEVICES		CHIP FORM (Y)
		SMALL OUTLINE (D)	PLASTIC DIP (P)	
0°C to 70°C	10 mV	TLC251CD	TLC251CP	TLC251Y
	5 mV	TLC251ACD	TLC251ACP	—
	2 mV	TLC251BCD	TLC251BCP	—

The D package is available taped and reeled. Add the suffix R to the device type (e.g., TLC251CDR). Chips are tested at 25°C.

LinCMOS is a trademark of Texas Instruments Incorporated.

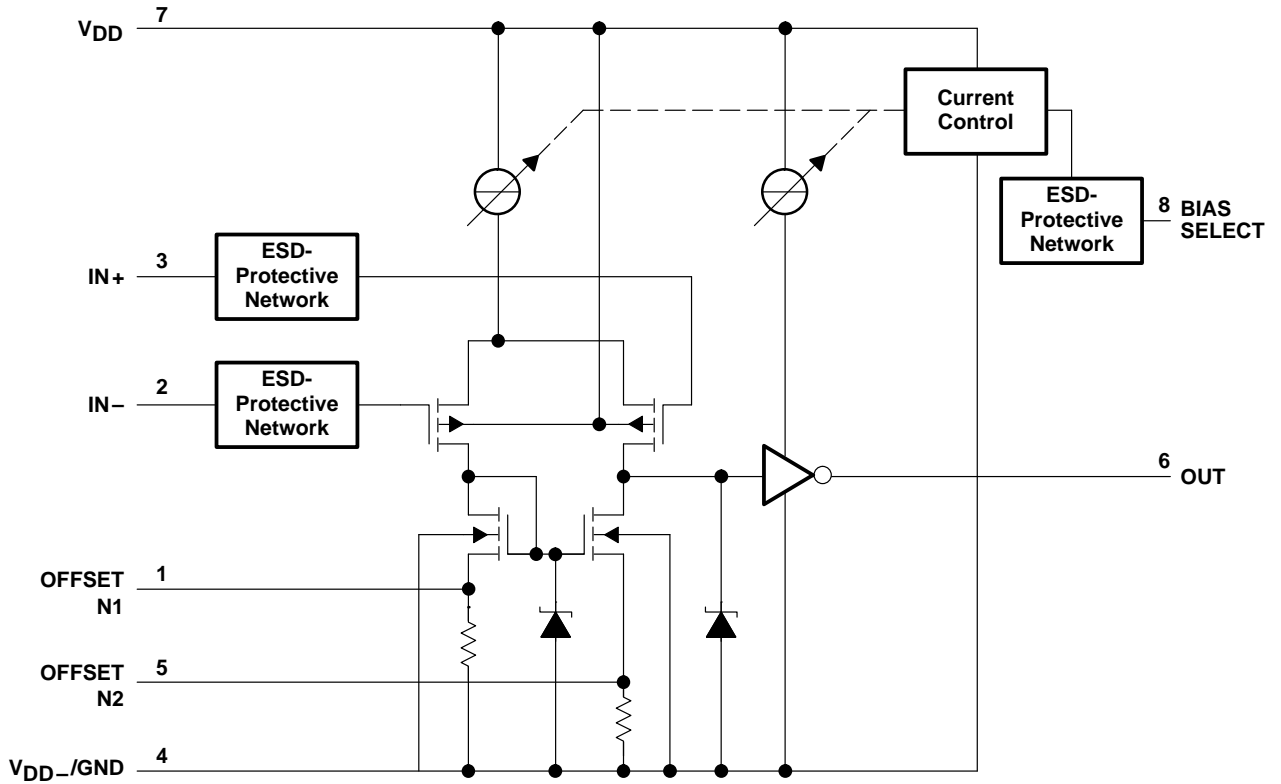
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



Copyright © 1994, Texas Instruments Incorporated

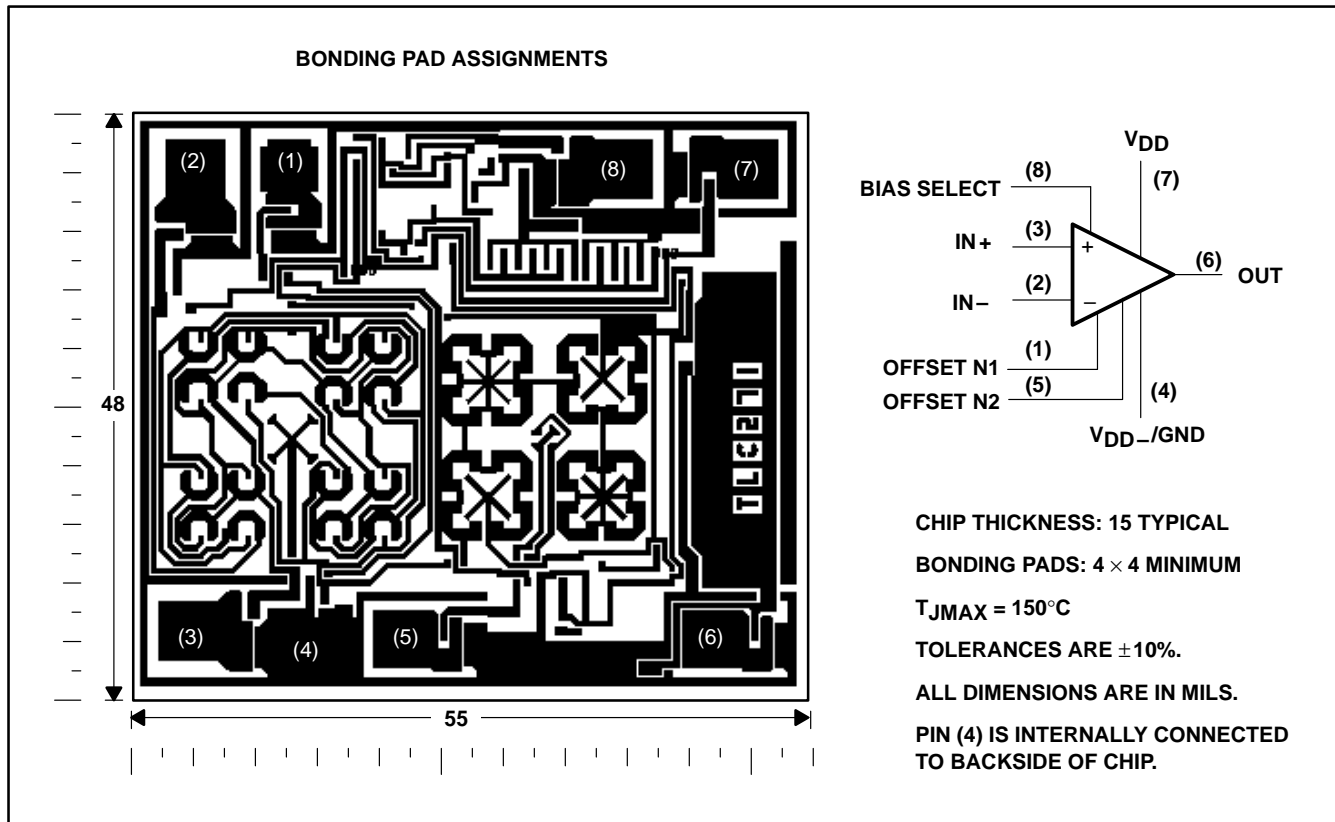
TLC251, TLC251A, TLC251B, TLC251Y
 LinCMOS™ PROGRAMMABLE
 LOW-POWER OPERATIONAL AMPLIFIERS
 SLOS001E – JULY 1983 – REVISED AUGUST 1994

schematic



TLC251Y chip information

These chips, properly assembled, display characteristics similar to the TLC251C. Thermal compression or ultrasonic bonding may be used on the doped-aluminum bonding pads. Chips may be mounted with conductive epoxy or a gold-silicon preform.



TLC251, TLC251A, TLC251B, TLC251Y
LinCMOS™ PROGRAMMABLE
LOW-POWER OPERATIONAL AMPLIFIERS

SLOS001E – JULY 1983 – REVISED AUGUST 1994

absolute maximum ratings over operating free-air temperature range (unless otherwise noted)†

Supply voltage, V_{DD} (see Note 1)	18 V
Differential input voltage, V_{ID} (see Note 2)	± 18 V
Input voltage range, V_I (any input)	-0.3 V to 18 V
Duration of short circuit at (or below) 25°C free-air temperature (see Note 3)	unlimited
Continuous total dissipation	See Dissipation Rating Table
Operating free-air temperature range, T_A	0°C to 70°C
Storage temperature range	-65°C to 150°C
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C

† Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
1. All voltage values, except differential voltages, are with respect to V_{DD-}/GND .
 2. Differential voltages are at $IN+$ with respect to $IN-$.
 3. The output may be shorted to either supply. Temperature and/or supply voltages must be limited to ensure the maximum dissipation rating is not exceeded.

DISSIPATION RATING TABLE

PACKAGE	$T_A \leq 25^\circ\text{C}$ POWER RATING	DERATING FACTOR ABOVE $T_A = 25^\circ\text{C}$	$T_A = 70^\circ\text{C}$ POWER RATING
D	725 mW	5.8 mW/°C	464 mW
P	1000 mW	8.0 mW/°C	640 mW

recommended operating conditions

		MIN	MAX	UNIT
Supply voltage, V_{DD}		1.4	16	V
Common-mode input voltage, V_{IC}	$V_{DD} = 1.4$ V	0	0.2	V
	$V_{DD} = 5$ V	-0.2	4	
	$V_{DD} = 10$ V	-0.2	9	
	$V_{DD} = 16$ V	-0.2	14	
Operating free-air temperature, T_A		0	70	°C
Bias-select voltage		See Application Information		

HIGH-BIAS MODE

electrical characteristics at specified free-air temperature

PARAMETER		TEST CONDITIONS	T _A †	TLC251C, TLC251AC, TLC251BC						UNIT
				V _{DD} = 5 V			V _{DD} = 10 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	TLC251C TLC251AC TLC251BC	V _O = 1.4 V, V _{IC} = 0 V, R _S = 50 Ω, R _L = 10 kΩ	25°C	1.1 10		1.1 10		mV	
				Full range	12		12			
				25°C	0.9 5		0.9 5			
				Full range	6.5		6.5			
				25°C	0.34 2		0.39 2			
				Full range	3		3			
α _{VIO}	Average temperature coefficient of input offset voltage		25°C to 70°C	1.8		2		μV/°C		
I _{IO}	Input offset current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.1		0.1		pA		
			70°C	7 300		7 300				
I _{IB}	Input bias current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.6		0.7		pA		
			70°C	40 600		50 600				
V _{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2 to 4	-0.3 to 4.2	-0.2 to 9	-0.3 to 9.2	V		
			Full range	-0.2 to 3.5		-0.2 to 8.5		V		
V _{OH}	High-level output voltage	V _{ID} = 100 mV, R _L = 10 kΩ	25°C	3.2 3.8		8 8.5		V		
			0°C	3 3.8		7.8 8.5				
			70°C	3 3.8		7.8 8.4				
V _{OL}	Low-level output voltage	V _{ID} = -100 mV, I _{OL} = 0	25°C	0 50		0 50		mV		
			0°C	0 50		0 50				
			70°C	0 50		0 50				
A _{VD}	Large-signal differential voltage amplification	R _L = 10 kΩ, See Note 6	25°C	5 23		10 36		V/mV		
			0°C	4 27		7.5 42				
			70°C	4 20		7.5 32				
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin}	25°C	65 80		65 85		dB		
			0°C	60 84		60 88				
			70°C	60 85		60 88				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V, V _O = 1.4 V	25°C	65 95		65 95		dB		
			0°C	60 94		60 94				
			70°C	60 96		60 96				
I _{I(SEL)}	Input current (BIAS SELECT)	V _{I(SEL)} = 0	25°C	-1.4		-1.9		μA		
I _{DD}	Supply current	V _O = V _{DD} /2, V _{IC} = V _{DD} /2, No load	25°C	675 1600		950 2000		μA		
			0°C	775 1800		1125 2200				
			70°C	575 1300		750 1700				

† Full range is 0°C to 70°C.

- NOTES:
4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.
 6. At V_{DD} = 5 V, V_O = 0.25 V to 2 V; at V_{DD} = 10 V, V_O = 1 V to 6 V.

HIGH-BIAS MODE

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 20\text{ pF}$	$V_{I(PP)} = 1\text{ V}$	25°C	3.6		V/ μ s
			0°C	4		
			70°C	3		
		$V_{I(PP)} = 2.5\text{ V}$	25°C	2.9		
			0°C	3.1		
			70°C	2.5		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\ \Omega$	25°C	25		nV/ $\sqrt{\text{Hz}}$	
B_{OM} Maximum output-swing bandwidth	$V_O = V_{OH}$, $C_L = 20\text{ pF}$, $R_L = 10\text{ k}\Omega$	25°C	320		kHz	
		0°C	340			
		70°C	260			
B_1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, $C_L = 20\text{ pF}$	25°C	1.7		MHz	
		0°C	2			
		70°C	1.3			
ϕ_m Phase margin	$V_I = 10\text{ mV}$, $f = B_1$, $C_L = 20\text{ pF}$	25°C	46°			
		0°C	47°			
		70°C	44°			

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS	T_A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 10\text{ k}\Omega$, $C_L = 20\text{ pF}$	$V_{I(PP)} = 1\text{ V}$	25°C	5.3		V/ μ s
			0°C	5.9		
			70°C	4.3		
		$V_{I(PP)} = 5.5\text{ V}$	25°C	4.6		
			0°C	5.1		
			70°C	3.8		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\ \Omega$	25°C	25		nV/ $\sqrt{\text{Hz}}$	
B_{OM} Maximum output-swing bandwidth	$V_O = V_{OH}$, $C_L = 20\text{ pF}$, $R_L = 10\text{ k}\Omega$	25°C	200		kHz	
		0°C	220			
		70°C	140			
B_1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, $C_L = 20\text{ pF}$	25°C	2.2		MHz	
		0°C	2.5			
		70°C	1.8			
ϕ_m Phase margin	$V_I = 10\text{ mV}$, $f = B_1$, $C_L = 20\text{ pF}$	25°C	49°			
		0°C	50°			
		70°C	46°			



MEDIUM-BIAS MODE

electrical characteristics at specified free-air temperature

PARAMETER		TEST CONDITIONS	T _A †	TLC251C, TLC251AC, TLC251BC						UNIT
				V _{DD} = 5 V			V _{DD} = 10 V			
				MIN	TYP	MAX	MIN	TYP	MAX	
V _{IO}	Input offset voltage	TLC251C TLC251AC TLC251BC	V _O = 1.4 V, V _{IC} = 0 V, R _S = 50 Ω, R _L = 10 kΩ	25°C	1.1 10		1.1 10		mV	
				Full range	12		12			
				25°C	0.9 5		0.9 5			
				Full range	6.5		6.5			
				25°C	0.34 2		0.39 2			
				Full range	3		3			
α _{VIO}	Average temperature coefficient of input offset voltage		25°C to 70°C	1.7		2.1		μV/°C		
I _{IO}	Input offset current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.1		0.1		pA		
			70°C	7 300		7 300				
I _{IB}	Input bias current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.6		0.7		pA		
			70°C	40 600		50 600				
V _{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2 to 4	-0.3 to 4.2	-0.2 to 9	-0.3 to 9.2	V		
			Full range	-0.2 to 3.5		-0.2 to 8.5		V		
V _{OH}	High-level output voltage	V _{ID} = 100 mV, R _L = 10 kΩ	25°C	3.2 3.9		8 8.7		V		
			0°C	3 3.9		7.8 8.7				
			70°C	3 4		7.8 8.7				
V _{OL}	Low-level output voltage	V _{ID} = -100 mV, I _{OL} = 0	25°C	0 50		0 50		mV		
			0°C	0 50		0 50				
			70°C	0 50		0 50				
A _{VD}	Large-signal differential voltage amplification	R _L = 10 kΩ, See Note 6	25°C	25 170		25 275		V/mV		
			0°C	15 200		15 320				
			70°C	15 140		15 230				
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin}	25°C	65 91		65 94		dB		
			0°C	60 91		60 94				
			70°C	60 92		60 94				
k _{SVR}	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V, V _O = 1.4 V	25°C	70 93		70 93		dB		
			0°C	60 92		60 92				
			70°C	60 94		60 94				
I _{I(SEL)}	Input current (BIAS SELECT)	V _{I(SEL)} = V _{DD} /2	25°C	-130		-160		nA		
I _{DD}	Supply current	V _O = V _{DD} /2, V _{IC} = V _{DD} /2, No load	25°C	105 280		143 300		μA		
			0°C	125 320		173 400				
			70°C	85 220		110 280				

† Full range is 0°C to 70°C.

- NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.
 6. At V_{DD} = 5 V, V_O = 0.25 V to 2 V; at V_{DD} = 10 V, V_O = 1 V to 6 V.



MEDIUM-BIAS MODE

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T _A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	R _L = 100 kΩ, C _L = 20 pF	V _{I(PP)} = 1 V	25°C	0.43		V/μs
			0°C	0.46		
			70°C	0.36		
		V _{I(PP)} = 2.5 V	25°C	0.40		
			0°C	0.43		
			70°C	0.34		
V _n Equivalent input noise voltage	f = 1 kHz, R _S = 20 Ω	25°C	32		nV/√Hz	
B _{OM} Maximum output-swing bandwidth	V _O = V _{OH} , C _L = 20 pF, R _L = 100 kΩ	25°C	55		kHz	
		0°C	60			
		70°C	50			
B ₁ Unity-gain bandwidth	V _I = 10 mV, C _L = 20 pF	25°C	525		kHz	
		0°C	600			
		70°C	400			
φ _m Phase margin	V _I = 10 mV, f = B ₁ , C _L = 20 pF	25°C	40°			
		0°C	41°			
		70°C	39°			

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS	T _A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	R _L = 100 kΩ, C _L = 20 pF	V _{I(PP)} = 1 V	25°C	0.62		V/μs
			0°C	0.67		
			70°C	0.51		
		V _{I(PP)} = 5.5 V	25°C	0.56		
			0°C	0.61		
			70°C	0.46		
V _n Equivalent input noise voltage	f = 1 kHz, R _S = 20 Ω	25°C	32		nV/√Hz	
B _{OM} Maximum output-swing bandwidth	V _O = V _{OH} , C _L = 20 pF, R _L = 100 kΩ	25°C	35		kHz	
		0°C	40			
		70°C	30			
B ₁ Unity-gain bandwidth	V _I = 10 mV, C _L = 20 pF	25°C	635		kHz	
		0°C	710			
		70°C	510			
φ _m Phase margin	V _I = 10 mV, f = B ₁ , C _L = 20 pF	25°C	43°			
		0°C	44°			
		70°C	42°			



LOW-BIAS MODE

electrical characteristics at specified free-air temperature

PARAMETER		TEST CONDITIONS	T _A †	TLC251C, TLC251AC, TLC251BC						UNIT	
				V _{DD} = 5 V			V _{DD} = 10 V				
				MIN	TYP	MAX	MIN	TYP	MAX		
V _{IO}	Input offset voltage	TLC251C TLC251AC TLC251BC	V _O = 1.4 V, V _{IC} = 0 V, R _S = 50 Ω, R _L = 10 MΩ	25°C	1.1		10	1.1		10	mV
				Full range			12			12	
				25°C	0.9		5	0.9		5	
				Full range			6.5			6.5	
				25°C	0.24		2	0.26		2	
				Full range			3			3	
α _{VIO}	Average temperature coefficient of input offset voltage		25°C to 70°C	1.1			1			μV/°C	
I _{IO}	Input offset current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.1			0.1			pA	
			70°C	7		300	7		300		
I _{IB}	Input bias current (see Note 4)	V _O = V _{DD} /2, V _{IC} = V _{DD} /2	25°C	0.6			0.7			pA	
			70°C	40		600	50		600		
V _{ICR}	Common-mode input voltage range (see Note 5)		25°C	-0.2 to 4	-0.3 to 4.2		-0.2 to 9	-0.3 to 9.2		V	
			Full range	-0.2 to 3.5			-0.2 to 8.5			V	
V _{OH}	High-level output voltage	V _{ID} = 100 mV, R _L = 1 MΩ	25°C	3.2	4.1		8	8.9		V	
			0°C	3	4.1		7.8	8.9			
			70°C	3	4.2		7.8	8.9			
V _{OL}	Low-level output voltage	V _{ID} = -100 mV, I _{OL} = 0	25°C	0		50	0		50	mV	
			0°C	0		50	0		50		
			70°C	0		50	0		50		
A _{VD}	Large-signal differential voltage amplification	R _L = 1 MΩ, See Note 6	25°C	50	520		50	870		V/mV	
			0°C	50	700		50	1030			
			70°C	50	380		50	660			
CMRR	Common-mode rejection ratio	V _{IC} = V _{ICRmin}	25°C	65	94		65	97		dB	
			0°C	60	95		60	97			
			70°C	60	95		60	97			
k _{SVR}	Supply-voltage rejection ratio (ΔV _{DD} /ΔV _{IO})	V _{DD} = 5 V to 10 V, V _O = 1.4 V	25°C	70	97		70	97		dB	
			0°C	60	97		60	97			
			70°C	60	98		60	98			
I _{I(SEL)}	Input current (BIAS SELECT)	V _{I(SEL)} = V _{DD}	25°C	65			95			nA	
I _{DD}	Supply current	V _O = V _{DD} /2, V _{IC} = V _{DD} /2, No load	25°C	10		17	14		23	μA	
			0°C	12		21	18		33		
			70°C	8		14	11		20		

† Full range is 0°C to 70°C.

- NOTES:
4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.
 5. This range also applies to each input individually.
 6. At V_{DD} = 5 V, V_O = 0.25 V to 2 V; at V_{DD} = 10 V, V_O = 1 V to 6 V.



LOW-BIAS MODE

operating characteristics, $V_{DD} = 5\text{ V}$

PARAMETER	TEST CONDITIONS	T_A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$	$V_{I(PP)} = 1\text{ V}$	25°C	0.03		V/ μ s
			0°C	0.04		
			70°C	0.03		
		$V_{I(PP)} = 2.5\text{ V}$	25°C	0.03		
			0°C	0.03		
			70°C	0.02		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\ \Omega$	25°C	68		nV/ $\sqrt{\text{Hz}}$	
B_{OM} Maximum output-swing bandwidth	$V_O = V_{OH}$, $C_L = 20\text{ pF}$, $R_L = 1\text{ M}\Omega$	25°C	5		kHz	
		0°C	6			
		70°C	4.5			
B_1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, $C_L = 20\text{ pF}$	25°C	85		kHz	
		0°C	100			
		70°C	65			
ϕ_m Phase margin	$V_I = 10\text{ mV}$, $f = B_1$, $C_L = 20\text{ pF}$	25°C	34°			
		0°C	36°			
		70°C	30°			

operating characteristics, $V_{DD} = 10\text{ V}$

PARAMETER	TEST CONDITIONS	T_A	TLC251C, TLC251AC, TLC251BC			UNIT
			MIN	TYP	MAX	
SR Slew rate at unity gain	$R_L = 1\text{ M}\Omega$, $C_L = 20\text{ pF}$	$V_{I(PP)} = 1\text{ V}$	25°C	0.05		V/ μ s
			0°C	0.05		
			70°C	0.04		
		$V_{I(PP)} = 5.5\text{ V}$	25°C	0.04		
			0°C	0.05		
			70°C	0.04		
V_n Equivalent input noise voltage	$f = 1\text{ kHz}$, $R_S = 20\ \Omega$	25°C	68		nV/ $\sqrt{\text{Hz}}$	
B_{OM} Maximum output-swing bandwidth	$V_O = V_{OH}$, $C_L = 20\text{ pF}$, $R_L = 1\text{ M}\Omega$	25°C	1		kHz	
		0°C	1.3			
		70°C	0.9			
B_1 Unity-gain bandwidth	$V_I = 10\text{ mV}$, $C_L = 20\text{ pF}$	25°C	110		kHz	
		0°C	125			
		70°C	90			
ϕ_m Phase margin	$V_I = 10\text{ mV}$, $f = B_1$, $C_L = 20\text{ pF}$	25°C	38°			
		0°C	40°			
		70°C	34°			



electrical characteristics at specified free-air temperature, $V_{DD} = 1.4\text{ V}$

PARAMETER		TEST CONDITION†	T_A ‡	BIAS	TLC251C, TLC251AC, TLC251BC			UNIT
					MIN	TYP	MAX	
V_{IO}	Input offset voltage	$V_O = 0.2\text{ V}, R_S = 50\ \Omega$	25°C	Any	10			mV
					Full range			
			25°C	Any	5			
					Full range			
			25°C	Any	2			
					Full range			
α_{VIO}	Average temperature coefficient of input offset voltage		25°C to 70°C	Any	1		$\mu\text{V}/^\circ\text{C}$	
I_{IO}	Input offset current	$V_O = 0.2\text{ V}$	25°C	Any	1		pA	
			Full range			300		
I_{IB}	Input bias current	$V_O = 0.2\text{ V}$	25°C	Any	1		pA	
			Full range			600		
V_{ICR}	Common-mode input voltage range		25°C	Any	0 to 0.2		V	
V_{OM}	Peak output voltage swing§	$V_{ID} = 100\text{ mV}$	25°C	Any	450	700	mV	
A_{VD}	Large-signal differential voltage amplification	$V_O = 100\text{ to }300\text{ mV}, R_S = 50\ \Omega$	25°C	Low	20			
				High	10			
CMRR	Common-mode rejection ratio	$R_S = 50\ \Omega, V_O = 0.2\text{ V}, V_{IC} = V_{ICRmin}$	25°C	Any	60	77	dB	
I_{DD}	Supply current	$V_O = 0.2\text{ V}, \text{ No load}$	25°C	Low	5	17	μA	
				High	150	190		

† All characteristics are measured under open-loop conditions with zero common-mode input voltage unless otherwise specified. Unless otherwise noted, an output load resistor is connected from the output to ground and has the following values: for low bias, $R_L = 1\text{ M}\Omega$, for medium bias, $R_L = 100\text{ k}\Omega$, and for high bias, $R_L = 10\text{ k}\Omega$.

‡ Full range is 0°C to 70°C.

§ The output swings to the potential of V_{DD-}/GND .

operating characteristics, $V_{DD} = 1.4\text{ V}, T_A = 25^\circ\text{C}$

PARAMETER		TEST CONDITIONS	BIAS	TLC251C, TLC251AC, TLC251BC			UNIT
				MIN	TYP	MAX	
B_1	Unity-gain bandwidth	$C_L = 100\text{ pF}$	Low	12			kHz
			High	12			
SR	Slew rate at unity gain	See Figure 1	Low	0.001			V/ μs
			High	0.1			
	Overshoot factor	See Figure 1	Low	35%			
			High	30%			

TLC251, TLC251A, TLC251B, TLC251Y
LinCMOS™ PROGRAMMABLE
LOW-POWER OPERATIONAL AMPLIFIERS

SLOS001E – JULY 1983 – REVISED AUGUST 1994

electrical characteristics, $V_{DD} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC251Y									UNIT
		HIGH-BIAS MODE			MEDIUM-BIAS MODE			LOW-BIAS MODE			
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX	
V_{IO} Input offset voltage	$V_O = 1.4\text{ V}$, $V_{IC} = 0\text{ V}$, $R_S = 50\ \Omega$, R_L^\dagger		1.1	10		1.1	10		1.1	10	mV
α_{VIO} Average temperature coefficient of input offset voltage			1.8			1.7			1.1		$\mu\text{V}/^\circ\text{C}$
I_{IO} Input offset current (see Note 4)	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$		0.1			0.1			0.1		pA
I_{IB} Input bias current (see Note 4)	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$		0.6			0.6			0.6		pA
V_{ICR} Common-mode input voltage range (see Note 5)		-0.2 to 4	-0.3 to 4.2		-0.2 to 4	-0.3 to 4.2		-0.2 to 4	-0.3 to 4.2		V
V_{OH} High-level output voltage	$V_{ID} = 100\text{ mV}$, R_L^\dagger	3.2	3.8		3.2	3.9		3.2	4.1		V
V_{OL} Low-level output voltage	$V_{ID} = -100\text{ mV}$, $I_{OL} = 0$		0	50		0	50		0	50	mV
A_{VD} Large-signal differential voltage amplification	$V_O = 0.25\text{ V}$, R_L^\dagger	5	23		25	170		50	480		V/mV
CMRR Common-mode rejection ratio	$V_{IC} = V_{ICRmin}$	65	80		65	91		65	94		dB
k_{SVR} Supply-voltage rejection ratio ($\Delta V_{DD}/\Delta V_{IO}$)	$V_{DD} = 5\text{ V to }10\text{ V}$, $V_O = 1.4\text{ V}$	65	95		70	93		70	97		dB
$I_{I(SEL)}$ Input current (BIAS SELECT)	$V_{I(SEL)} = V_{DD}/2$		-1.4			-0.13			0.065		μA
I_{DD} Supply current	$V_O = V_{DD}/2$, $V_{IC} = V_{DD}/2$, No load		675	1600		105	280		10	17	μA

† For high-bias mode, $R_L = 10\text{ k}\Omega$; for medium-bias mode, $R_L = 100\text{ k}\Omega$; and for low-bias mode, $R_L = 1\text{ M}\Omega$.

NOTES: 4. The typical values of input bias current and input offset current below 5 pA were determined mathematically.

5. This range also applies to each input individually.



operating characteristics, $V_{DD} = 5\text{ V}$, $T_A = 25^\circ\text{C}$

PARAMETER	TEST CONDITIONS	TLC251Y									UNIT			
		HIGH-BIAS MODE			MEDIUM-BIAS MODE			LOW-BIAS MODE						
		MIN	TYP	MAX	MIN	TYP	MAX	MIN	TYP	MAX				
SR	Slew rate at unity gain R_L^\dagger , $C_L = 20\text{ pF}$	$V_I(\text{PP}) = 1\text{ V}$			3.6			0.43			0.03			V/ μs
		$V_I(\text{PP}) = 2.5\text{ V}$			2.9			0.40			0.03			
V_n	Equivalent input noise voltage $f = 1\text{ kHz}$, $R_S = 20\ \Omega$	25			32			68			nV/ $\sqrt{\text{Hz}}$			
B_{OM}	Maximum output swing bandwidth $V_O = V_{\text{OH}}$, $R_L = 10\text{ k}\Omega$	$C_L = 20\text{ pF}$, 320			55			4.5			kHz			
B_1	Unity-gain bandwidth $V_I = 10\text{ mV}$, $C_L = 20\text{ pF}$	1700			525			65			kHz			
ϕ_m	Phase margin $f = B_1$, $C_L = 20\text{ pF}$	$V_I = 10\text{ mV}$, 46°			40°			34°						

† For high-bias mode, $R_L = 10\text{ k}\Omega$; for medium-bias mode, $R_L = 100\text{ k}\Omega$; and for low-bias mode, $R_L = 1\text{ M}\Omega$.

PARAMETER MEASUREMENT INFORMATION

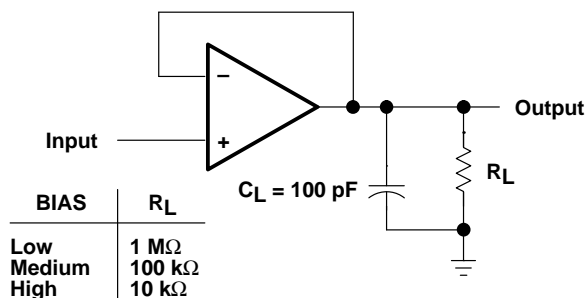


Figure 1. Unity-Gain Amplifier

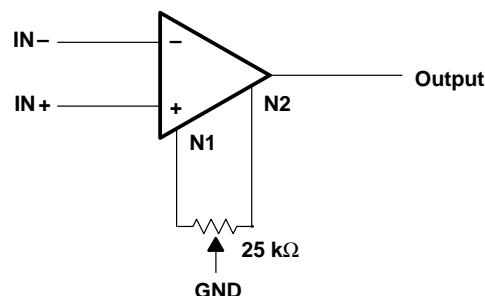


Figure 2. Input Offset Voltage Null Circuit

TYPICAL CHARACTERISTICS

Table of Graphs

		FIGURE	
I_{DD}	Supply current	vs Bias-select voltage	3
		vs Supply voltage	4
		vs Free-air temperature	5
A_{VD}	Large-signal differential voltage amplification	Low bias vs Frequency	6
		Medium bias vs Frequency	7
		High bias vs Frequency	8
	Phase shift	Low bias vs Frequency	6
		Medium bias vs Frequency	7
		High bias vs Frequency	8

TYPICAL CHARACTERISTICS

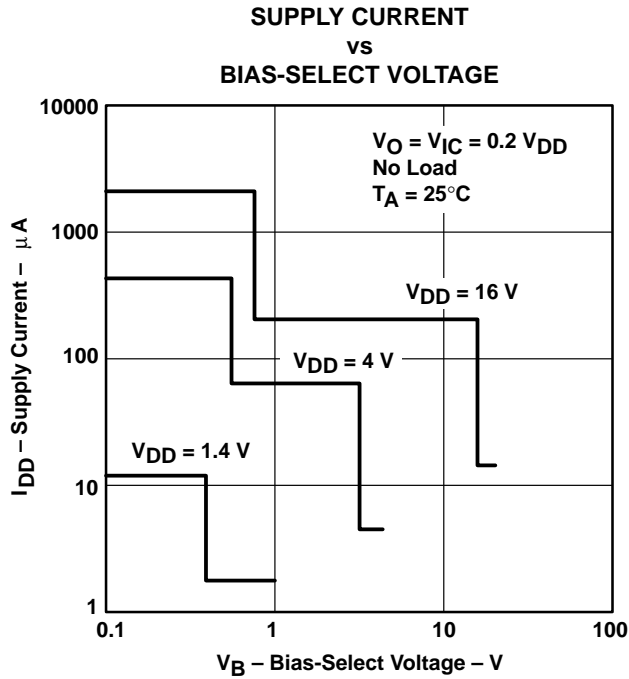


Figure 3

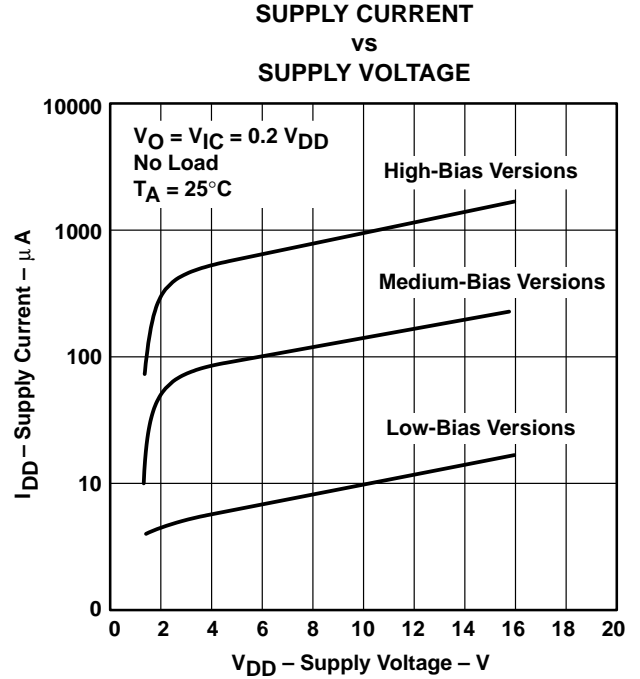


Figure 4

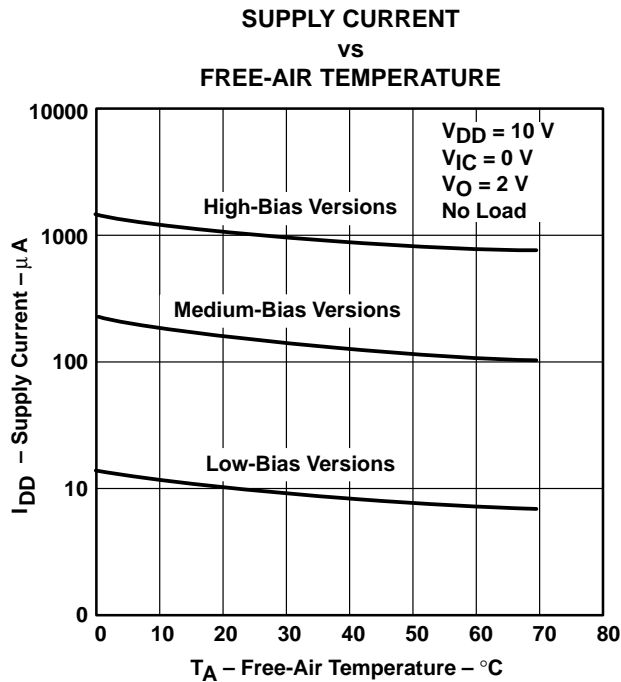


Figure 5

TYPICAL CHARACTERISTICS

**LOW-BIAS LARGE-SIGNAL
 DIFFERENTIAL VOLTAGE AMPLIFICATION
 AND PHASE SHIFT
 VS
 FREQUENCY**

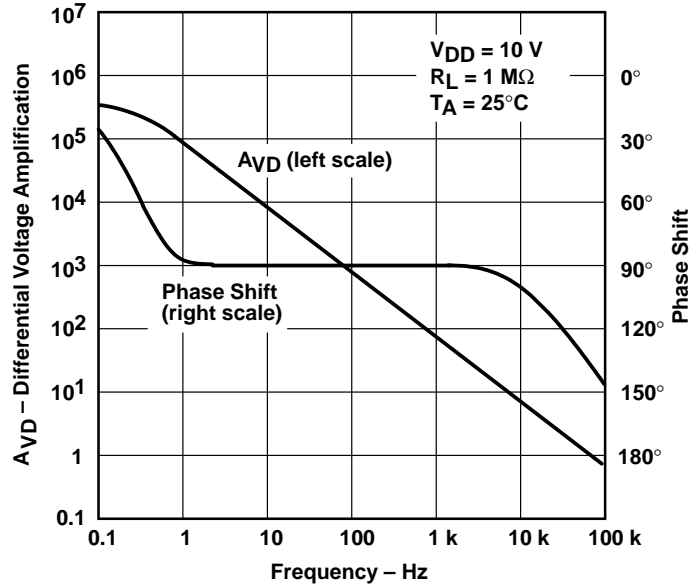


Figure 6

**MEDIUM-BIAS LARGE-SIGNAL
 DIFFERENTIAL VOLTAGE AMPLIFICATION
 AND PHASE SHIFT
 VS
 FREQUENCY**

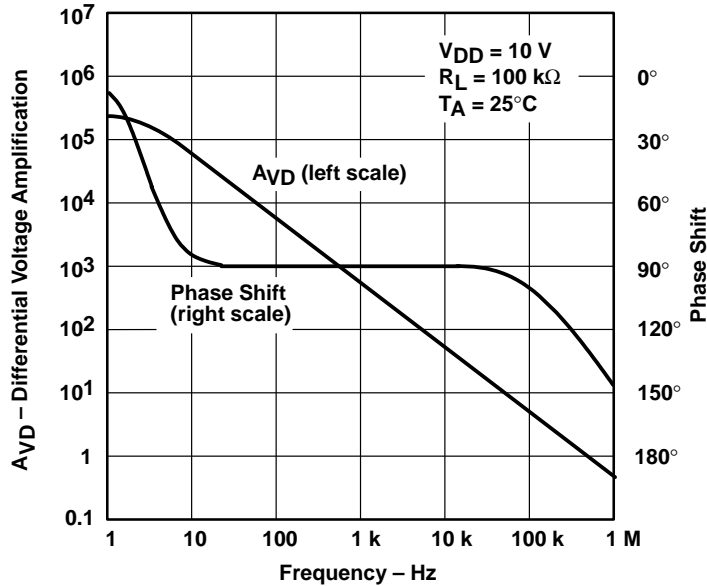


Figure 7



TYPICAL CHARACTERISTICS

HIGH-BIAS LARGE-SIGNAL DIFFERENTIAL VOLTAGE AMPLIFICATION AND PHASE SHIFT VS FREQUENCY

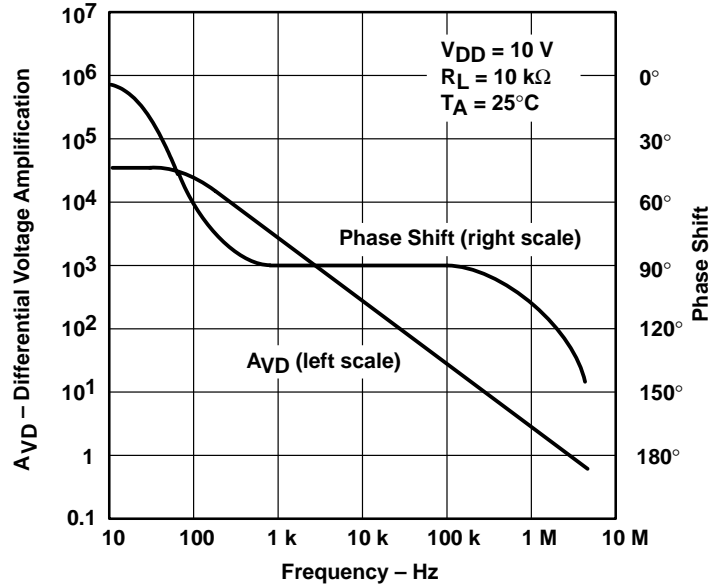


Figure 8

APPLICATION INFORMATION

latch-up avoidance

Junction-isolated CMOS circuits have an inherent parasitic PNP structure that can function as an SCR. Under certain conditions, this SCR may be triggered into a low-impedance state, resulting in excessive supply current. To avoid such conditions, no voltage greater than 0.3 V beyond the supply rails should be applied to any pin. In general, the operational amplifier supplies should be applied simultaneously with, or before, application of any input signals.

APPLICATION INFORMATION

using BIAS SELECT

The TLC251 has a terminal called BIAS SELECT that allows the selection of one of three I_{DD} conditions (10, 150, and 1000 μA typical). This allows the user to trade-off power and ac performance. As shown in the typical supply current (I_{DD}) versus supply voltage (V_{DD}) curves (Figure 4), the I_{DD} varies only slightly from 4 V to 16 V. Below 4 V, the I_{DD} varies more significantly. Note that the I_{DD} values in the medium- and low-bias modes at $V_{DD} = 1.4\text{ V}$ are typically 2 μA , and in the high mode are typically 12 μA . The following table shows the recommended BIAS SELECT connections at $V_{DD} = 10\text{ V}$.

BIAS MODE	AC PERFORMANCE	BIAS SELECT CONNECTION†	TYPICAL $I_{DD}‡$
Low	Low	V_{DD}	10 μA
Medium	Medium	0.8 V to 9.2 V	150 μA
High	High	Ground pin	1000 μA

† Bias selection may also be controlled by external circuitry to conserve power, etc. For information regarding BIAS SELECT, see Figure 3 in the typical characteristics curves.

‡ For I_{DD} characteristics at voltages other than 10 V, see Figure 4 in the typical characteristics curves.

output stage considerations

The amplifier's output stage consists of a source-follower-connected pullup transistor and an open-drain pulldown transistor. The high-level output voltage (V_{OH}) is virtually independent of the I_{DD} selection and increases with higher values of V_{DD} and reduced output loading. The low-level output voltage (V_{OL}) decreases with reduced output current and higher input common-mode voltage. With no load, V_{OL} is essentially equal to the potential of V_{DD-}/GND .

input offset nulling

The TLC251C series offers external offset null control. Nulling may be achieved by adjusting a 25-k Ω potentiometer connected between the offset null terminals with the wiper connected to the device V_{DD-}/GND pin as shown in Figure 2. The amount of nulling range varies with the bias selection. At an I_{DD} setting of 1000 μA (high bias), the nulling range allows the maximum offset specified to be trimmed to zero. In low or medium bias or when the amplifier is used below 4 V, total nulling may not be possible for all units.

supply configurations

Even though the TLC251C series is characterized for single-supply operation, it can be used effectively in a split-supply configuration when the input common-mode voltage (V_{ICR}), output swing (V_{OL} and V_{OH}), and supply voltage limits are not exceeded.

circuit layout precautions

The user is cautioned that whenever extremely high circuit impedances are used, care must be exercised in layout, construction, board cleanliness, and supply filtering to avoid hum and noise pickup, as well as excessive dc leakages.

IMPORTANT NOTICE

Texas Instruments (TI) reserves the right to make changes to its products or to discontinue any semiconductor product or service without notice, and advises its customers to obtain the latest version of relevant information to verify, before placing orders, that the information being relied on is current.

TI warrants performance of its semiconductor products and related software to the specifications applicable at the time of sale in accordance with TI's standard warranty. Testing and other quality control techniques are utilized to the extent TI deems necessary to support this warranty. Specific testing of all parameters of each device is not necessarily performed, except those mandated by government requirements.

Certain applications using semiconductor products may involve potential risks of death, personal injury, or severe property or environmental damage ("Critical Applications").

TI SEMICONDUCTOR PRODUCTS ARE NOT DESIGNED, INTENDED, AUTHORIZED, OR WARRANTED TO BE SUITABLE FOR USE IN LIFE-SUPPORT APPLICATIONS, DEVICES OR SYSTEMS OR OTHER CRITICAL APPLICATIONS.

Inclusion of TI products in such applications is understood to be fully at the risk of the customer. Use of TI products in such applications requires the written approval of an appropriate TI officer. Questions concerning potential risk applications should be directed to TI through a local SC sales office.

In order to minimize risks associated with the customer's applications, adequate design and operating safeguards should be provided by the customer to minimize inherent or procedural hazards.

TI assumes no liability for applications assistance, customer product design, software performance, or infringement of patents or services described herein. Nor does TI warrant or represent that any license, either express or implied, is granted under any patent right, copyright, mask work right, or other intellectual property right of TI covering or relating to any combination, machine, or process in which such semiconductor products or services might be or are used.